# **NPN Silicon Power Darlington Transistors**

The Darlington transistors are designed for high-voltage power switching in inductive circuits.

### **Features**

• These Devices are Pb-Free and are RoHS Compliant

### **Applications**

- Small Engine Ignition
- Switching Regulators
- Inverters
- Solenoid and Relay Drivers
- Motor Controls

### **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V <sub>CEO(sus)</sub>	400	Vdc
Collector-Emitter Voltage	V <sub>CEV</sub>	800	Vdc
Emitter-Base Voltage	V <sub>EB</sub>	8	Vdc
Collector Current – Continuous – Peak (Note 1)	I <sub>C</sub>	8 16	Adc
Base Current – Continuous – Peak (Note 1)	I <sub>B</sub> I <sub>BM</sub>	2.5 5	Adc
Total Device Dissipation @ T <sub>A</sub> = 25°C Derate above 25°C	P <sub>D</sub>	2 0.016	W W/°C
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	100 0.8	W W/°C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-65 to +150	°C

### THERMAL CHARACTERISTICS

Characteristics	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	1.25	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 5 Seconds	$T_L$	275	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

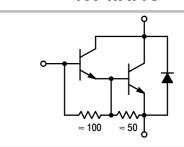
1. Pulse Test: Pulse Width = 5 ms, Duty Cycle ≤ 10%.

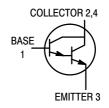


### ON Semiconductor®

http://onsemi.com

# POWER DARLINGTON **TRANSISTORS** 8 AMPERES, 400 VOLTS **100 WATTS**





### **MARKING DIAGRAM**



1

D<sup>2</sup>PAK **CASE 418B** STYLE 1



B5742 = Specific Device Code = Assembly Location

= Year

WW = Work Week = Pb-Free Package

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
MJB5742T4G	D <sup>2</sup> PAK (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# FLECTRICAL CHARACTERISTICS (T.

ELECTRICAL CHARAC	<b>TERISTICS</b> ( $T_C = 25^{\circ}C$ unless otherwise noted)					
	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS	(Note 2)					
Collector-Emitter Sustainir	V <sub>CEO(sus)</sub>	400	-	-	Vdc	
Collector Cutoff Current (V (V <sub>CEV</sub> = Rated Value, V <sub>E</sub>	I <sub>CEV</sub>	- -	- -	1 5	mAdc	
Emitter Cutoff Current (VEE	I <sub>EBO</sub>	-	-	75	mAdc	
SECOND BREAKDOWN						
Second Breakdown Collect	Second Breakdown Collector Current with Base Forward Biased			See Figure 6		
Clamped Inductive SOA wi	th Base Reverse Biased	RBSOA	See Figure 7			
ON CHARACTERISTICS (N	Note 2)					
DC Current Gain (I <sub>C</sub> = 0.5 A (I <sub>C</sub> = 4 Adc, V <sub>CE</sub> = 5 Vdc	h <sub>FE</sub>	50 200	100 400	_ _	_	
Collector-Emitter Saturation	V <sub>CE(sat)</sub>	- - -	- - -	2 3 2.2	Vdc	
Base-Emitter Saturation Vo	V <sub>BE(sat)</sub>	- - -	- - -	2.5 3.5 2.4	Vdc	
Diode Forward Voltage (Note 3) (I <sub>F</sub> = 5 Adc) V <sub>f</sub> 2.5				2.5	Vdc	
SWITCHING CHARACTER	ISTICS					
Typical Resistive Load (T	able 1)					
Delay Time		t <sub>d</sub>	-	0.04	-	μs
Rise Time	(V <sub>CC</sub> = 250 Vdc, I <sub>C(pk)</sub> = 6 A	t <sub>r</sub>	-	0.5	-	μs
Storage Time	l <sub>B1</sub> = l <sub>B2</sub> = 0.25 A, t <sub>p</sub> = 25 μs, Duty Cycle ≤ 1%)	ts	_	8	_	μs
Fall Time		t <sub>f</sub>	_	2	_	μs
Inductive Load, Clamped	(Table 1)		I	I	I	1
Voltage Storage Time	(I <sub>C(pk)</sub> = 6 A, V <sub>CE(pk)</sub> = 250 Vdc	t <sub>sv</sub>	_	4	_	μs
Crossover Time	1 . " ' " '		_	2	-	μs
	1 1	t <sub>c</sub>		1		

Pulse Test: Pulse Width 300 μs, Duty Cycle = 2%.
 The internal Collector-to-Emitter diode can eliminate the need for an external diode to clamp inductive loads. Tests have shown that the Forward Recovery Voltage (V<sub>f</sub>) of this diode is comparable to that of typical fast recovery rectifiers.

### **TYPICAL CHARACTERISTICS**

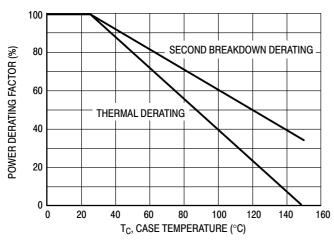


Figure 1. Power Derating

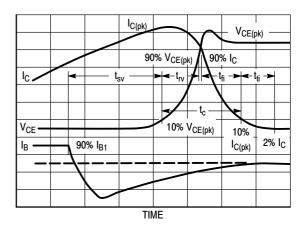


Figure 2. Inductive Switching Measurements

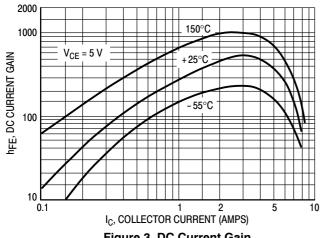


Figure 3. DC Current Gain

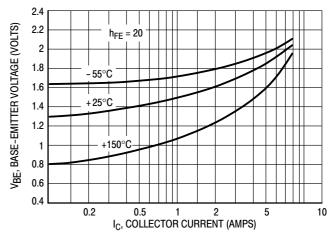


Figure 4. Base-Emitter Voltage

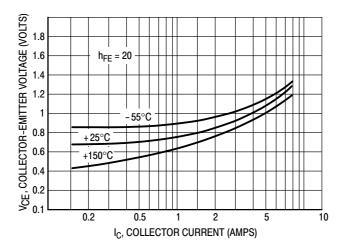


Figure 5. Collector-Emitter Saturation Voltage

**Table 1. Test Conditions for Dynamic Performance** 

	REVERSE BIAS SAFE OPERATING AREA AND INDUCTIVE SWITCHING	RESISTIVE SWITCHING
TEST CIRCUITS	DUTY CYCLE $\leq$ 10% $_{1}$ $_{1}$ $_{2}$ $_{1}$ $_{3}$ $_{3}$ $_{1}$ $_{3}$ $_{3}$ $_{1}$ $_{3}$ $_{3}$ $_{1}$ $_{3}$ $_{3}$ $_{1}$ $_{3}$ $_{3}$ $_{1}$ $_{3}$ $_{4}$ $_{5}$ $_{1}$ $_{5}$ $_{1}$ $_{1}$ $_{1}$ $_{1}$ $_{2}$ $_{1}$ $_{2}$ $_{1}$ $_{2}$ $_{$	+V <sub>CC</sub> R <sub>C</sub> TUT  SCOPE  1  -4V
CIRCUIT	COIL DATA: GAP FOR 200 $\mu$ H/20 A $V_{CC} = 30$ V $V_{CE(pk)} = 250$ Vdc FULL BOBBIN (~16 TURNS) #16 $V_{Coil} = 200$ $\mu$ H $V_{Cc(pk)} = 250$ Vdc $V_{Ce(pk)} = 6$ A	V <sub>CC</sub> = 250 V D1 = 1N5820 OR EQUIV.
TEST WAVEFORMS	OUTPUT WAVEFORMS $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$+10 \text{ V}$ $25 \mu\text{S}$ $-9.2 \text{ V}$ $+10 \text{ N}$ $-9.2 \text{ V}$ $+10 \text{ N}$ $+10$

### SAFE OPERATING AREA INFORMATION

# **FORWARD BIAS**

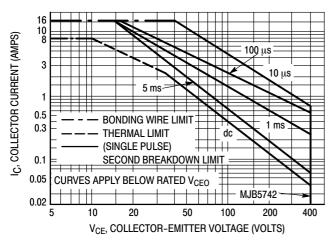
There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate  $I_C - V_{CE}$  limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 6 is based on  $T_C = 25^{\circ}C$ ;  $T_{J(pk)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C \ge 25^{\circ}C$ . Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 6 may be found at any case temperature by using the appropriate curve on Figure 1.

### **REVERSE BIAS**

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe Operating Area and represents the voltage-current condition allowable during reverse biased turnoff. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 7 gives the complete RBSOA characteristics.

The Safe Operating Area figures shown in Figures 6 and 7 are specified ratings for these devices under the test conditions shown.



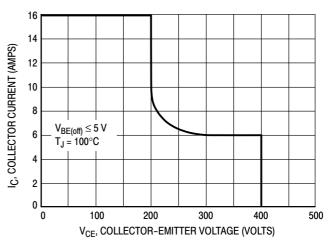


Figure 6. Forward Bias Safe Operating Area

Figure 7. Reverse Bias Safe Operating Area

### RESISTIVE SWITCHING PERFORMANCE

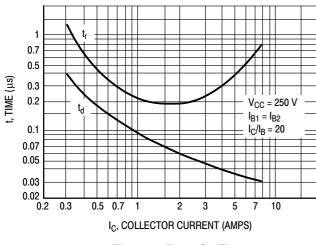


Figure 8. Turn-On Time

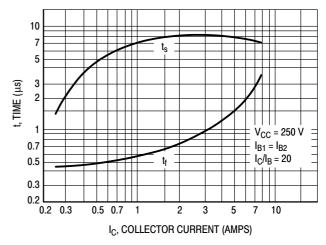
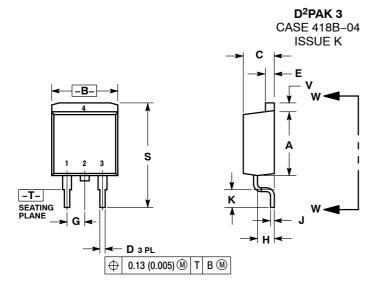


Figure 9. Turn-Off Time

### PACKAGE DIMENSIONS



### NOTES:

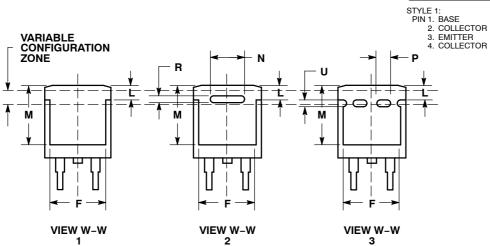
- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

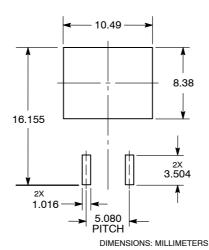
  2. CONTROLLING DIMENSION: INCH.

  3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.340	0.380	8.64	9.65	
В	0.380	0.405	9.65	10.29	
С	0.160	0.190	4.06	4.83	
D	0.020	0.035	0.51	0.89	
E	0.045	0.055	1.14	1.40	
F	0.310	0.350	7.87	8.89	
G	0.100 BSC		2.54 BSC		
Н	0.080	0.110	2.03 2.79		
J	0.018	0.025	0.46	0.64	
K	0.090	0.110	2.29	2.79	
L	0.052	0.072	1.32	1.83	
М	0.280	0.320	7.11	8.13	
N	0.197 REF		5.00 REF		
P	0.079 REF		2.00 REF		
R	0.039 REF		0.99 REF		
S	0.575	0.625	14.60	15.88	
V	0.045	0.055	1.14	1.40	



### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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